MOSFET - N-Channel Shielded Gate PowerTrench®

150 V, 31 mΩ, 31 A

NTMFS034N15MC

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low QG and Capacitance to Minimize Driver Losses
- 100% UIL Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Synchronous Rectification
- AC-DC and DC-DC Power Supplies
- AC-DC Adapters (USB PD) SR
- Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	150	V	
Gate-to-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current R _{θJC} (Note 2)	Steady State	T _C = 25°C	I _D	31	Α
Power Dissipation $R_{\theta JC}$ (Note 2)			P_{D}	62.5	W
Continuous Drain Current R _{0JA} (Notes 1, 2)	Steady	eady tate $T_A = 25^{\circ}C$	Ι _D	6.1	Α
Power Dissipation R _{θJA} (Notes 1, 2)	State		P _D	2.5	W
Pulsed Drain Current	T _C = 25°	C, t _p = 100 μs	I _{DM}	131	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Single Pulse Drain-to-Source Avalanche Energy (I _L = 6 A _{pk} , L = 3 mH)		E _{AS}	54	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

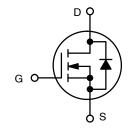
- 1. Surface-mounted on FR4 board using a 1 in2, 2 oz. Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	31 mΩ @ 10 V	31 A



N-CHANNEL MOSFET



MARKING DIAGRAM



3415MC = Specific Device Code = Assembly Location Α

Υ = Year W = Work Week ZΖ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]		
NTMFS034N15MC	Power 56	3000 / Tape		
(Pb-Free/Halogen Free)	(PQFN8)	& Reel		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	2.0	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	50	

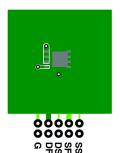
ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		150			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			86		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 120 V	T _J = 25°C			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 70 \mu A$		2.5		4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 70 μA, ref to 25°C			-7.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 13 A			25	31	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 8 V, I _D = 6 A			27	36.5	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 13 A			27		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 75 V			905		pF
Output Capacitance	C _{OSS}				270		
Reverse Transfer Capacitance	C _{RSS}				5		
Gate-Resistance	R_{G}				0.6	1.2	Ω
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 75 V; I _D = 13 A			12		nC
Threshold Gate Charge	Q _{G(TH)}				3.1		
Gate-to-Source Charge	Q_{GS}				4.8		
Gate-to-Drain Charge	Q_{GD}				1.8		
Plateau Voltage	V_{GP}				5.4		V
Output Charge	Q _{OSS}	V _{DD} = 75 V, V _{GS} = 0 V			32		nC
SWITCHING CHARACTERISTICS (Note 3)							
Turn-On Delay Time	t _{d(ON)}				12		
Rise Time	t _r	V_{GS} = 10 V, V_{DD} = 75 V, I_{D} = 13 A, R_{G} = 6 Ω			2.2		ns
Turn-Off Delay Time	t _{d(OFF)}				14		
Fall Time	t _f				2.5		
DRAIN-SOURCE DIODE CHARACTERISTIC	es						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 13 \text{ A}$	T _J = 25°C		0.87	1.2	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD} = 75 V dl _S /dt = 300 A/μs, l _S = 13 A			41		ns
Reverse Recovery Charge	Q _{RR}				126		nC
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, V_{DD} = 75 \text{ V}$ $dI_S/dt = 1000 \text{ A}/\mu\text{s}, I_S = 13 \text{ A}$			22		ns
Reverse Recovery Charge	Q _{RR}				164		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- Switching characteristics are independent of operating junction temperatures.
 R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R_{θCA} is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

TYPICAL CHARACTERISTICS

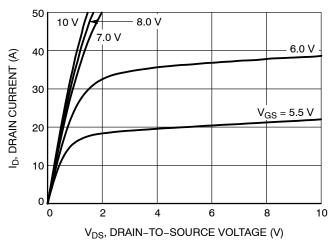


Figure 1. On-Region Characteristics

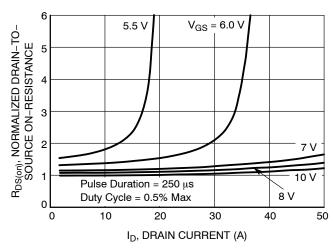


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

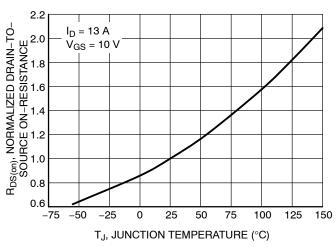


Figure 3. Normalized On–Resistance vs. Junction Temperature

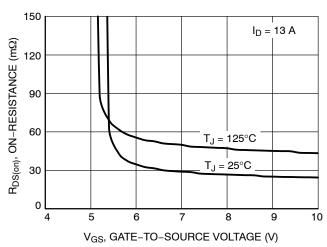


Figure 4. On-Resistance vs. Gate-to-Source Voltage

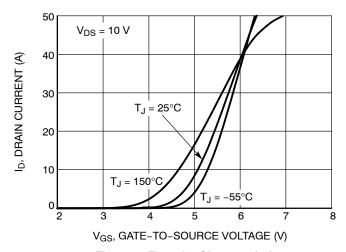


Figure 5. Transfer Characteristics

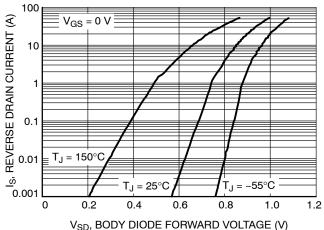
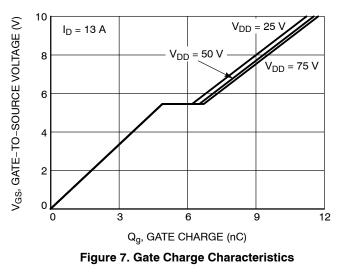


Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS



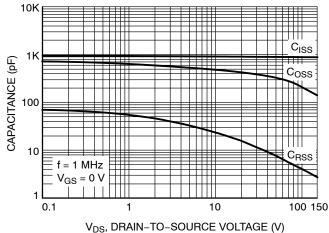


Figure 8. Capacitance vs. Drain-to-Source Voltage

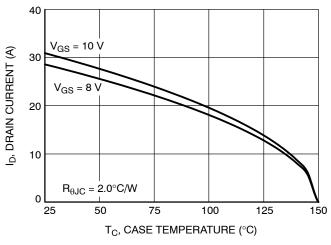


Figure 9. Drain Current vs. Case Temperature

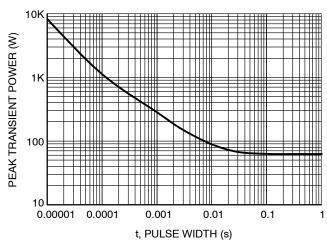


Figure 10. Peak Power

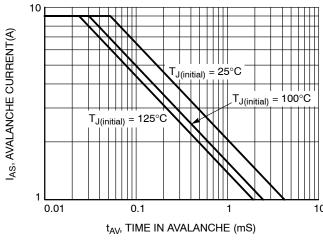


Figure 11. Unclamped Inductive Switching Capability

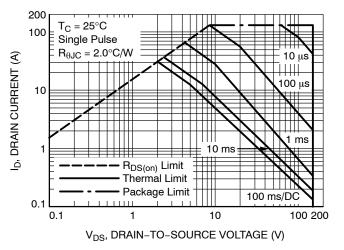


Figure 12. Forward Bias Safe Operating Area

TYPICAL CHARACTERISTICS

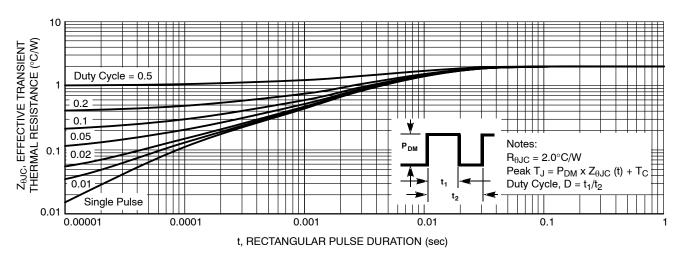
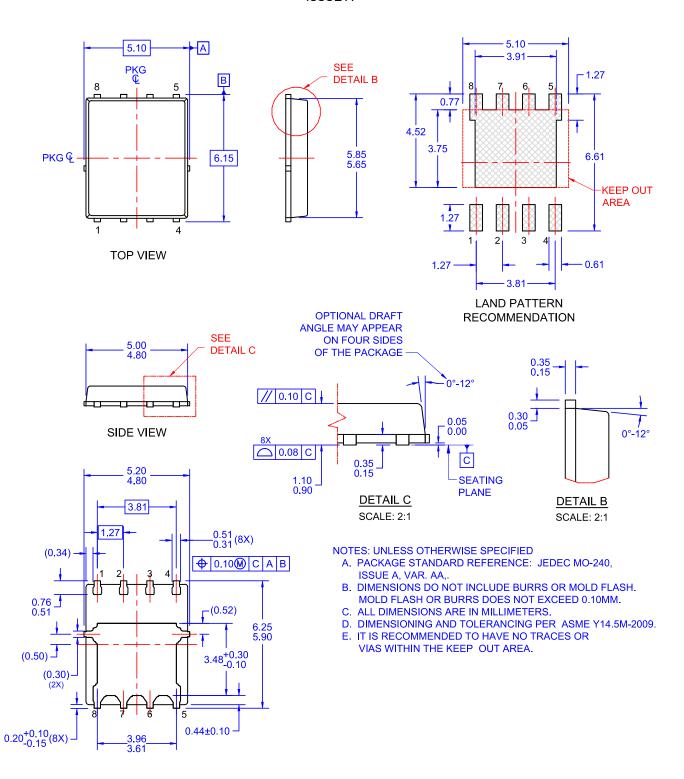


Figure 13. Transient Thermal Impedance

PACKAGE DIMENSIONS

PQFN8 5X6, 1.27P CASE 483AE ISSUE A



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